# Shining Light on Dark Matter, One Photon at a Time

by

### Brandon Leigh Allen

Submitted to the Department of Physics in partial fulfillment of the requirements for the degree of

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#### Abstract

A search is conducted for new physics in final states containing a photon and missing transverse momentum in proton-proton collisions at  $\sqrt{s}=13$  TeV. The data collected by the CMS experiment at the CERN LHC correspond to an integrated luminosity of 35.9 inverse femtobarns. No deviations from the predictions of the standard model are observed. The results are interpreted in the context of dark matter production and limits on new physics parameters are calculated at 95% confidence level. For the two simplified dark matter production models considered, the observed (expected) lower limits on the mediator masses are both 950 (1150) GeV for 1 GeV dark matter mass.

Thesis Supervisor: Christoph E.M. Paus

Title: Professor

### Acknowledgments

This is the acknowledgements section. You should replace this with your own acknowledgements.

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# Introduction

Things to be introduced.

### Motivation

Why I did this.

### 2.1 Astrophysical Evidence for Dark Matter

Galactic Rotation Curves and the Bullet Cluster.

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It was the hot thing at the time.

### The CMS Detector

The big thing we know and love.

#### 3.1 Detector Overview

What are the parts.

#### 3.1.1 Silicon Pixel Detector

The tiny dots.

#### 3.1.2 Silicon Strip Tracker

The thin strips.

#### 3.1.3 Electromagnetic Calorimeter

Our  $PbWO_4$  guys.

#### 3.1.4 Hadronic Calorimeter

Our big brassy boi.

### 3.1.5 Muon Detectors

The red ones.

### Reconstruction

#### 4.1 Reconstruction

How do we turn electrical signals into physics.

#### 4.1.1 Particle Flow

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The main event.

#### 5.1 Event Selection

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Using the transfer factor  $R_{\ell\ell}^Z$ , the total estimated event yield  $T_{\ell\ell}$  in each dilepton control region in the  $i^{\rm th}$  bin of the  $E_{\rm T}$  distribution can be expressed as

$$T_{\ell\ell,i} = \frac{N_i^Z}{R_{\ell\ell,i}^Z} + b_{\ell\ell,i},\tag{5.1}$$

where  $N^Z$  is the number of  $Z(\to)+$  events in the combined signal regions and  $b_{\ell\ell}$  is the predicted contribution from other background sources in the dilepton control region, namely  $t\bar{t}$  VV, and misidentified hadrons. The subscript i indicates that the quantities are evaluated in bin i of the  $E_{\rm T}$  distribution.

Using  $R_{\ell}^W$  and  $f_W^Z$ , the total estimated event yield  $T_{\ell}$  in each single-lepton control region in the *i*th bin of the  $E_{\rm T}$  distribution can be expressed as

$$T_{\ell,i} = \frac{N_i^Z}{R_{\ell,i}^W f_{W,i}^Z} + b_{\ell,i}, \tag{5.2}$$

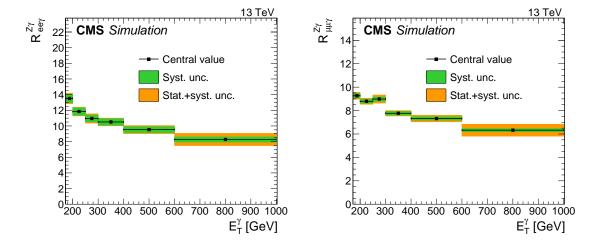


Figure 5-1: Transfer factors  $R_{ee}^Z$  (left) and  $R_{\mu\mu}^Z$  (right). The uncertainty bands in green (inner) and orange (outer) show the systematic uncertainty, and the combination of systematic and statistical uncertainty arising from limited MC sample size, respectively. The systematic uncertainties considered are the uncertainties in the data-to-simulation correction factors  $\rho$  for the lepton identification efficiencies. Simulated  $Z(\to \ell\bar{\ell})+$  events are generated in two samples, one with generated  $E_{\rm T}$  required to be greater than 300 GeV, and one with a looser restriction. The  $E_{\rm T}$  bin centred at 270 GeV is close to the boundary between the two samples, where there are fewer generated events. The relatively large statistical fluctuation visible in the third bin of the right-hand figure results from this.

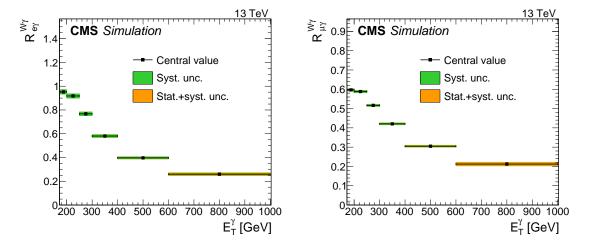


Figure 5-2: Transfer factors  $R_e^W$  (left) and  $R_\mu^W$  (right). The uncertainty bands in green (inner) and orange (outer) show the systematic uncertainty, and the combination of systematic and statistical uncertainty arising from limited MC sample size, respectively. The systematic uncertainties considered are the uncertainties in the data-to-simulation correction factors  $\rho$  for the lepton identification efficiencies.

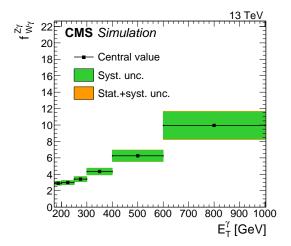


Figure 5-3: Transfer factor  $f_W^Z$ . The uncertainty bands in green (inner) and orange (outer) show the systematic uncertainty, and the combination of systematic and statistical uncertainty arising from limited MC sample size, respectively. The systematic uncertainties considered are the uncertainties from higher-order theoretical corrections.

where  $b_{\ell}$  is the predicted contribution from other background sources in the single-lepton regions, namely misidentified electrons and hadrons and other minor SM processes.

- 5.3 Misidentified backgrounds
- 5.3.1 Electrons
- 5.3.2 Hadrons
- 5.4 Non-collision backgrounds
- 5.4.1 Spikes
- 5.4.2 Beam halo
- 5.5 Statistical Interpretation
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# Comparison with Other Results

We're not doing this in a vacuum.

- 6.1 Monophoton
- 6.2 Monojet / Mono-Z
- 6.3 Direct Detection
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# Conclusion

Things to conclude.